Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/600,996	CHAN ET AL.
Examiner	Art Unit
Navneet K. Ahluwalia	2166

SEARCHED				
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707	1-10 100-104.1 200-205	6/28/2006	NKA	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		·	

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
Consulted Supervisory Patent Examiner, Hosain Alam, AU 2166	6/28/2006	NKA
Consulted Primary Examiner, Mohammad Ali, AU 2166	6/28/2006	NKA
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